

<b>Notice of References Cited</b>	Application/Control No. 10/629,546	Applicant(s)/Patent Under Reexamination FURUMIYA ET AL.	
	Examiner Kim-Kwok CHU	Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,513,165	04-1996	Ide et al.	369/116
*	B	US-4,873,680	10-1989	Chung et al.	369/59.12
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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